

Product Features

Frequency: 20MHz~700MHz

Noise Figure: 1.2dB@400MHz

Gain: 10.9dB@400MHz

Output Third-Order Interception:

43.6dBm@400MHz

Output Power for 1dB Compression:

24.1dBm@400MHz

Vdd=+5V, static current 100mA~160mA

Package: Compatible with SMO-8C

General Description

BR8122AFF is a surface-mount, PCB substrate-based anti-blocking amplifier with a shielded metal enclosure, which covers a frequency range of 20MHz~700MHz. At 400MHz, the amplifier typically offers a gain of 10.9dB, an output IP3 of 43.6dBm and a noise figure of 1.2dB under the condition of +5V power supply. The product delivers excellent gain flatness across a wide frequency band, combined with high linearity, making it suitable for high-performance transceiver systems.

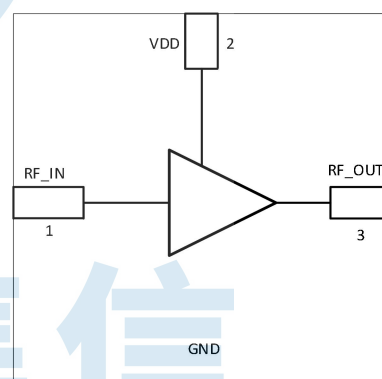
Applications

Ultrashort-Wave Application

Large Dynamic Range Receiver

Anti-blocking Amplification System

Functional Block Diagram



Ordering Information

Part Number	Package	Description
BR8122AFF	Compatible SMO-8C	20MHz ~ 700MHz Anti-Blocking amplifier

Electrical Specifications

Parameters	Min.	Typ.	Max.	Units	Test Condition
Gain	-	10.9	-	dB	400MHz
Output Power for 1dB Compression	-	24.1	-	dBm	400MHz
Output Third-Order Interception	-	43.6	-	dBm	400MHz
Noise Figure	-	1.2	-	dB	400MHz
Input Return Loss	-	-12.3	-	dB	400MHz
Output Return Loss	-	-14.7	-	dB	400MHz
Reverse Isolation	-	-14.1	-	dB	400MHz
Supply Voltage	-	5	-	V	-
Supply Current	100	127	160	mA	-

Test Conditions: Vdd=+5V, OIP3 spacing=1MHz, Pout=+10dBm/tone, TA=+25°C

Absolute Maximum Ratings

Maximum Operating Voltage (Vdd): +9V

Maximum RF Input Power:

+17dBm (+5V Supply Voltage)

Maximum RF Input Power:

+19dBm (+9V Supply Voltage)

ESD Rating: Class 1C (< 1600V)

Note: Operation of the device outside the parameter ranges given absolute-maximum-ratings conditions may cause permanent damage, and, exposure to absolute-maximum-ratings conditions for extended periods will affect the reliability.

Recommended Working Conditions

Power Supply Voltage: +5V

Static Working Current: 100mA~160mA

Working Temperature: -55°C ~ +85°C

Storage Temperature: -65°C ~ +125°C

ESD WARNING

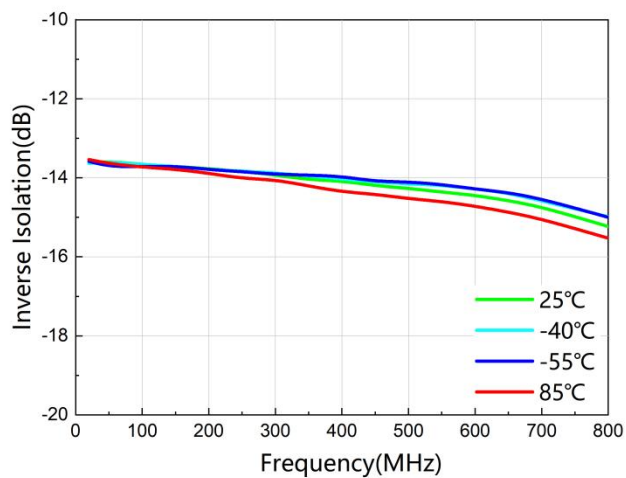
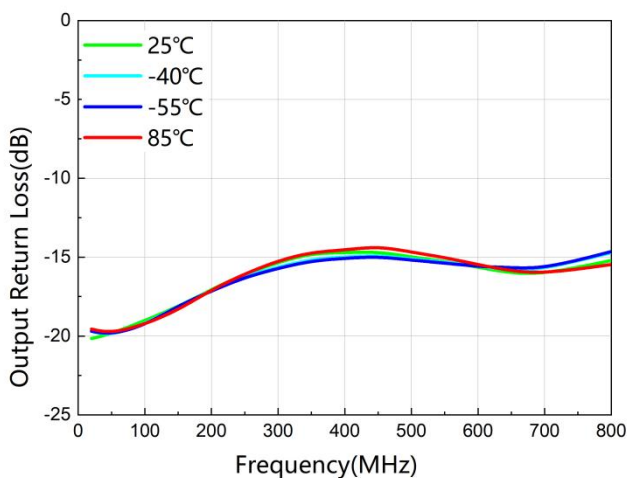
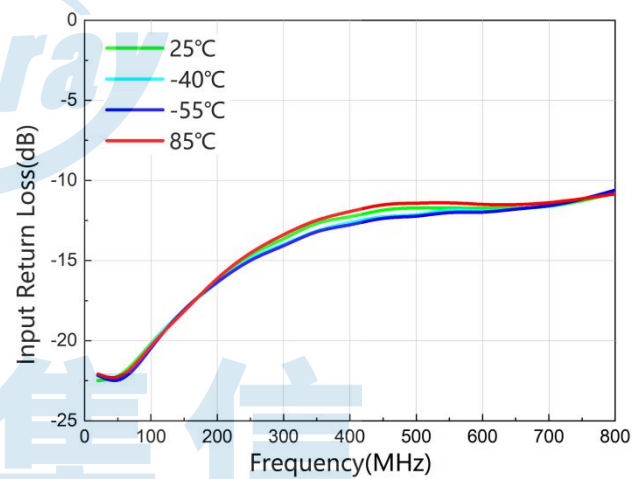
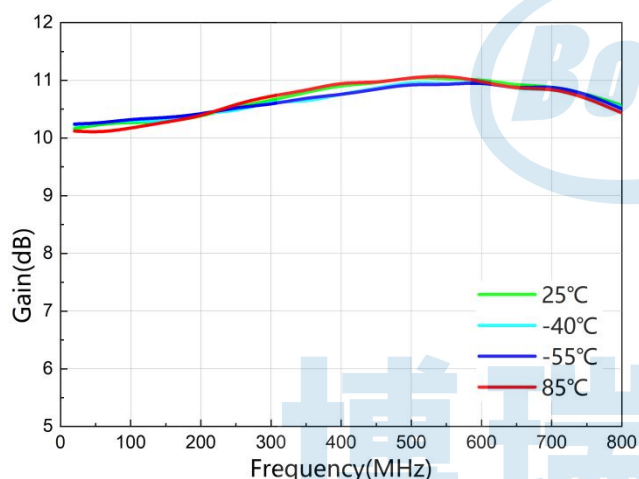


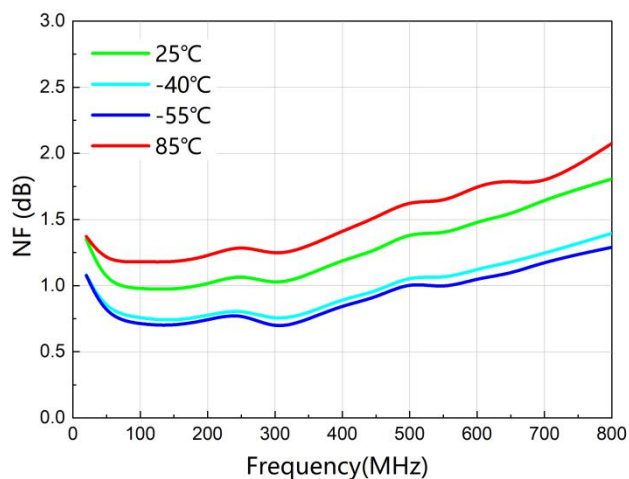
ELECTROSTATIC SENSITIVE DEVICE
OBSERVE HANDLING PRECAUTIONS

Typical Performance(EVB test results at +5V supply voltage, 20MHz~1000MHz, 25°C)

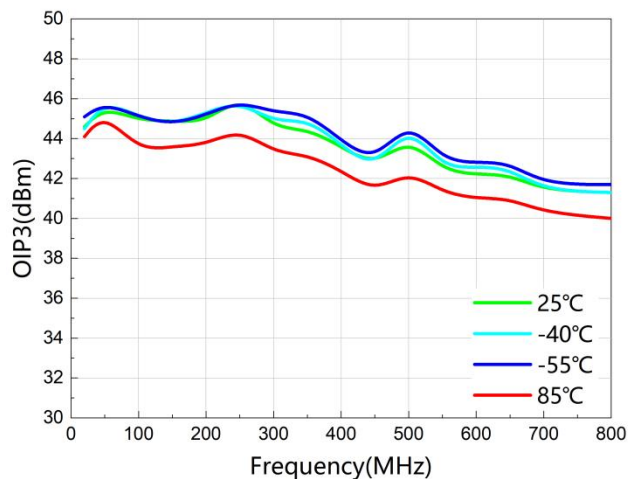
Parameters	Typ.									Units
Frequency	20	50	100	200	300	400	500	600	700	MHz
Gain	10.2	10.2	10.3	10.4	10.7	10.9	11.0	11.0	10.9	dB
Input Return Loss	-22.5	-22.2	-20.2	-16.2	-13.6	-12.3	-11.7	-11.7	-11.6	dB
Output Return Loss	-20.2	-19.8	-19.0	-17.1	-15.3	-14.7	-15.0	-15.6	-16.1	dB
Isolation	-13.6	-13.6	-13.7	-13.8	-13.9	-14.1	-14.3	-14.4	-14.7	dB
Input Power for 1dB Compression	14.6	14.7	14.5	14.5	14.6	14.3	14.0	15.0	14.6	dBm
Output Power for 1dB Compression	24.0	23.9	23.8	23.9	24.2	24.1	24.0	24.6	24.1	dBm
Output Third-Order Intercept	44.6	45.6	44.9	44.8	44.5	43.6	44.1	42.2	41.4	dBm
Noise Figure	1.4	1.0	1.0	1.0	1.0	1.2	1.4	1.5	1.7	dB

Test Conditions: Vdd=+5V, I=127mA, OIP3 spacing=1MHz, Pout=+10dBm/100kHz, TA=+25°C

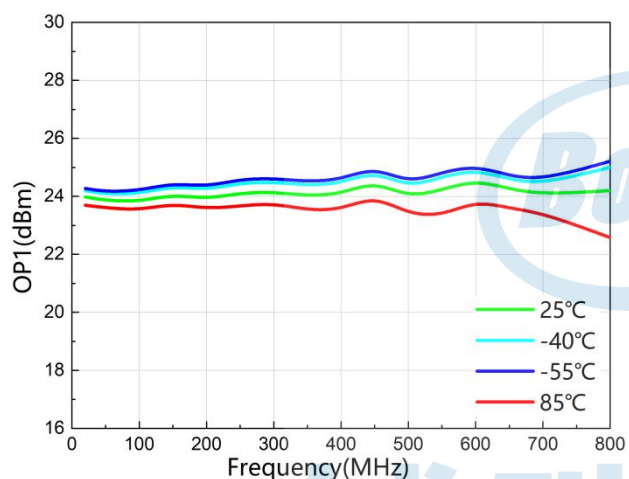




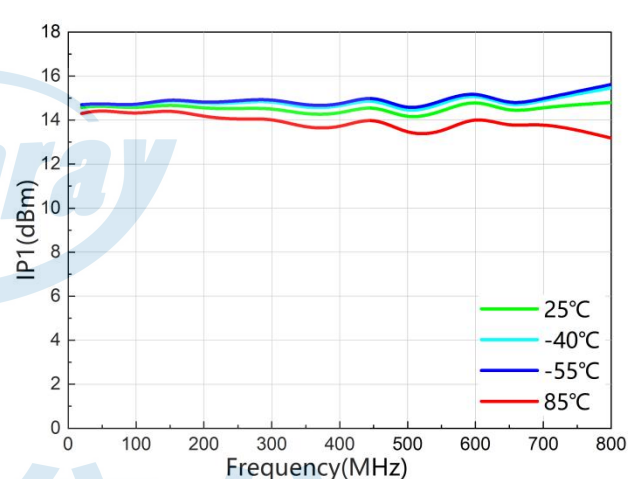
Noise Figure vs. Freq



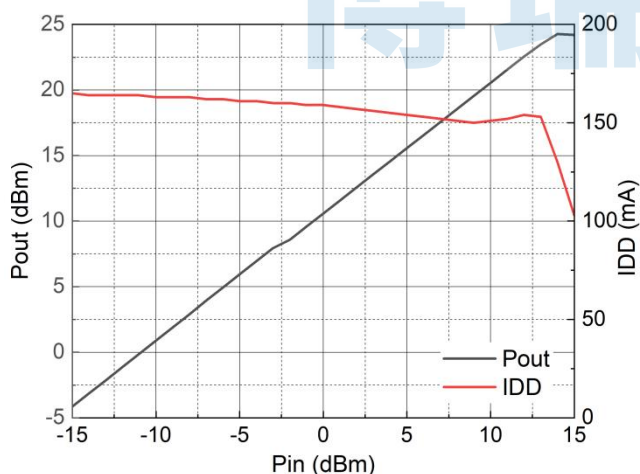
Output Third-Order Intercept vs. Freq



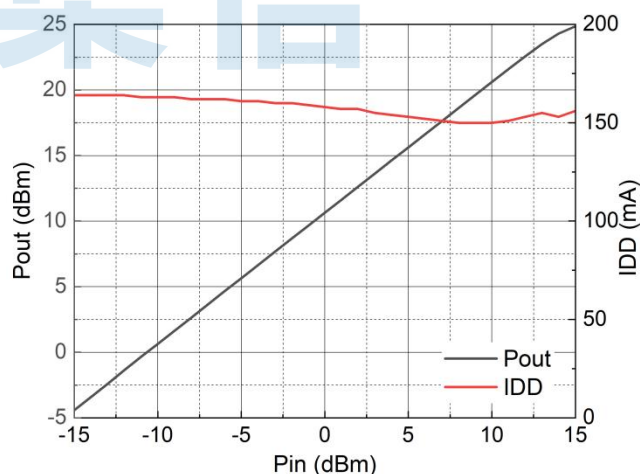
Output Power for 1dB Compression vs. Freq



Input Power for 1dB Compression vs. Freq



P_{out}, IDD vs P_{in} (400MHz)

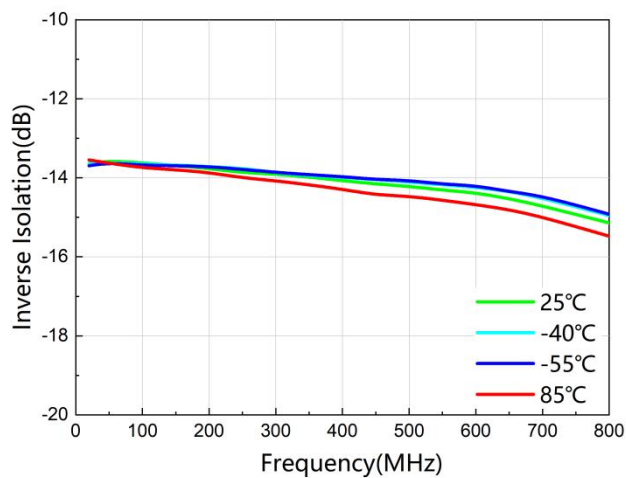
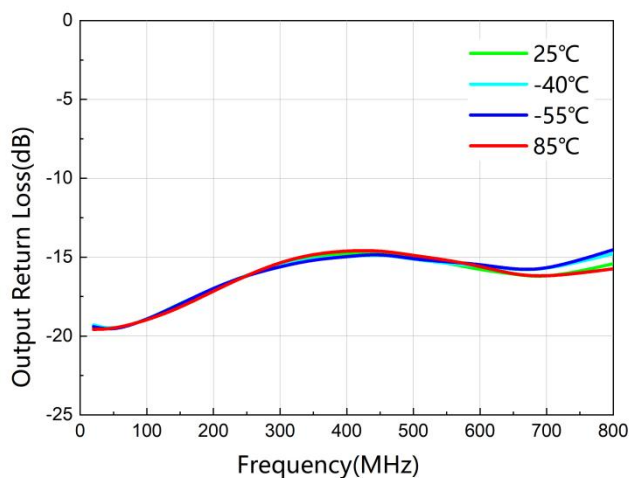
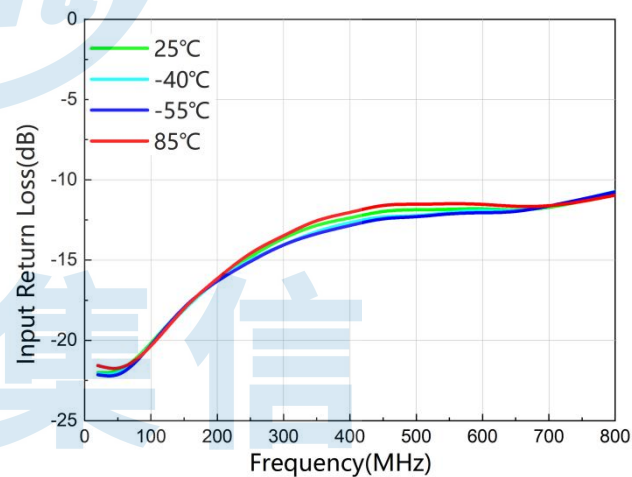
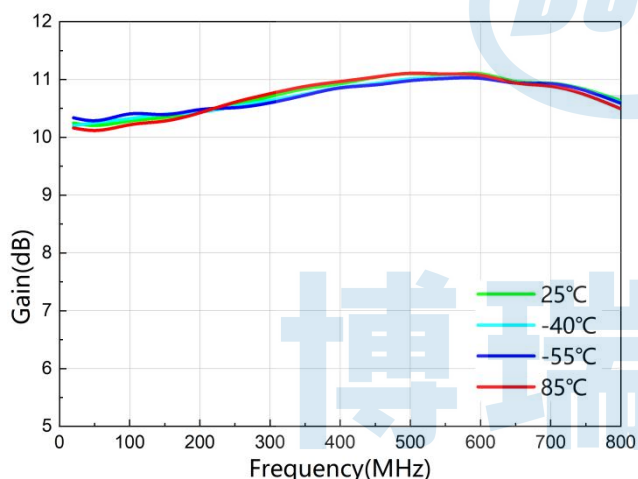


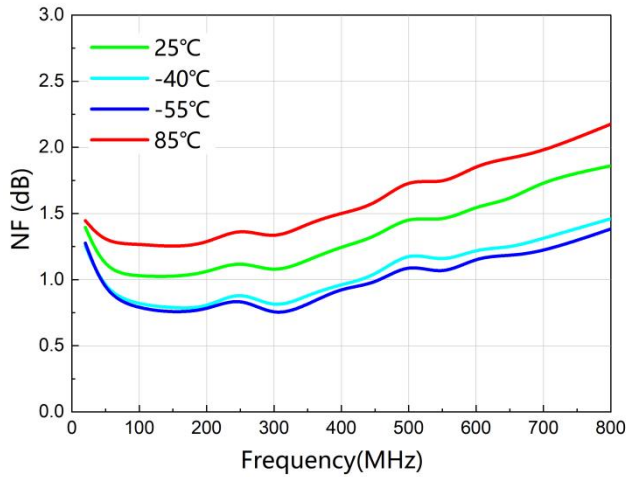
P_{out}, IDD vs P_{in} (700MHz)

Typical Performance((EVB test results at +6V supply voltage, 20MHz~700MHz, 25°C)

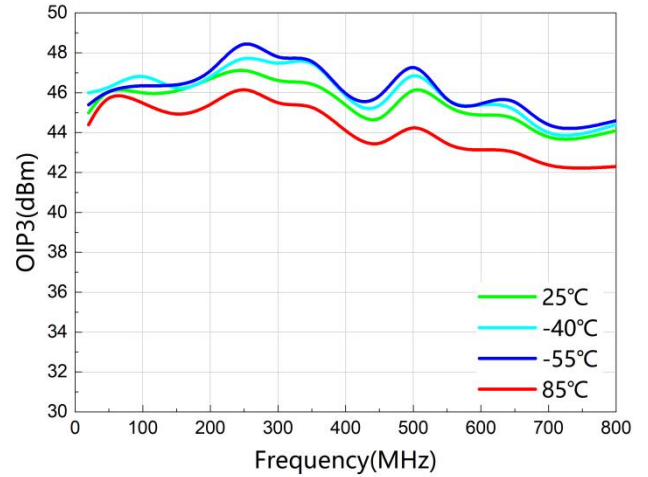
Parameters	Typ.									Units
Frequency	20	50	100	200	300	400	500	600	700	MHz
Gain	10.2	10.2	10.3	10.5	10.7	10.9	11.1	11.1	10.9	dB
Input Return Loss	-22.0	-21.9	-20.2	-16.3	-13.6	-12.4	-11.9	-11.8	-11.7	dB
Output Return Loss	-19.5	-19.6	-19.0	-17.0	-15.4	-14.8	-15.0	-15.8	-16.4	dB
Isolation	-13.6	-13.6	-13.6	-13.8	-13.9	-14.1	-14.2	-14.4	-14.7	dB
Input Power for 1dB Compression	16.0	16.1	15.9	15.9	15.9	15.6	15.3	16.2	15.9	dBm
Output Power for 1dB Compression	25.5	25.3	25.2	25.3	25.5	25.5	25.4	25.9	25.4	dBm
Output Third-Order Intercept	45.0	46.4	45.9	46.7	46.4	45.4	46.9	44.8	43.3	dBm
Noise Figure	1.4	1.1	1.0	1.1	1.0	1.3	1.5	1.6	1.8	dB

Test Conditions: Vdd=+6V, I=180mA, OIP3 spacing=1MHz, Pout=+10dBm/1tone, TA=+25°C

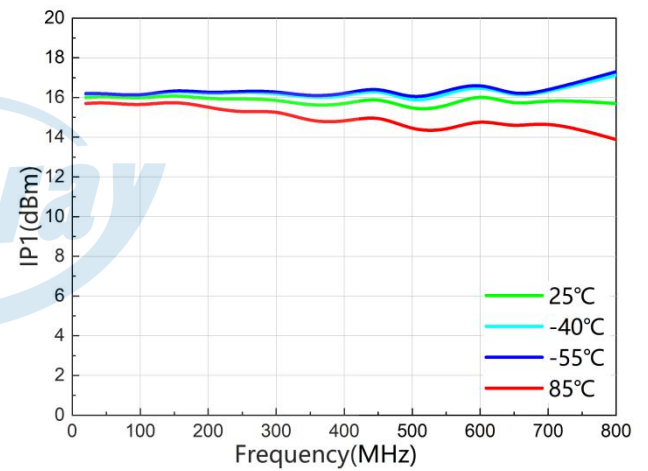
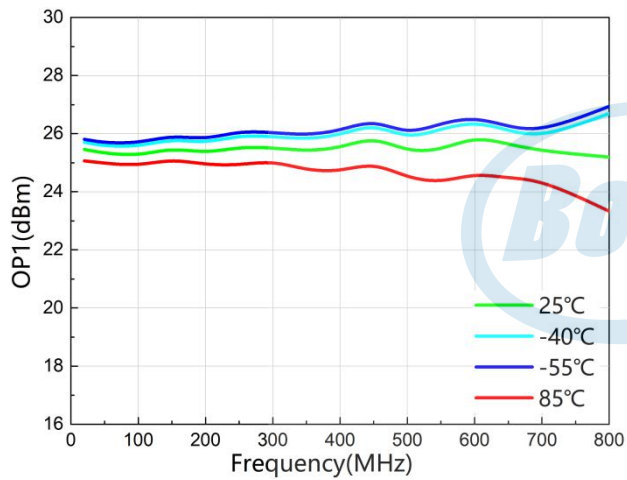




Noise Figure vs. Freq

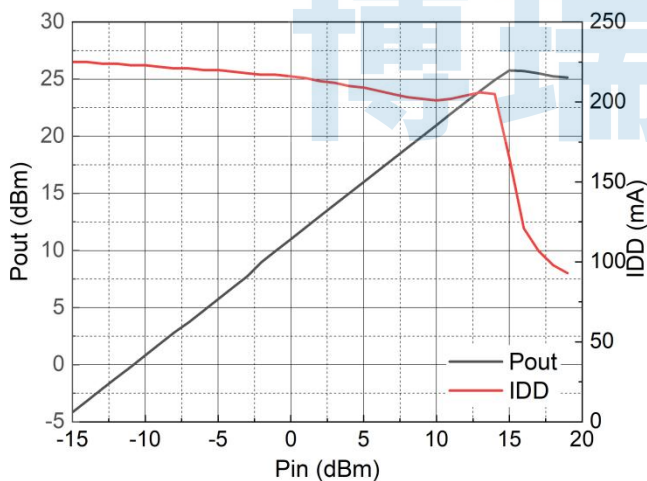


Output Third-Order Intercept vs. Freq

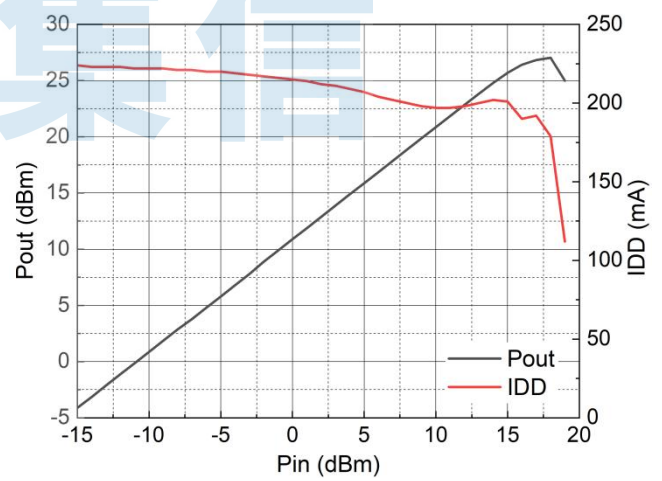


Output Power for 1dB Compression vs. Freq

Input Power for 1dB Compression vs. Freq



P_{out} , IDD vs P_{in} (400MHz)

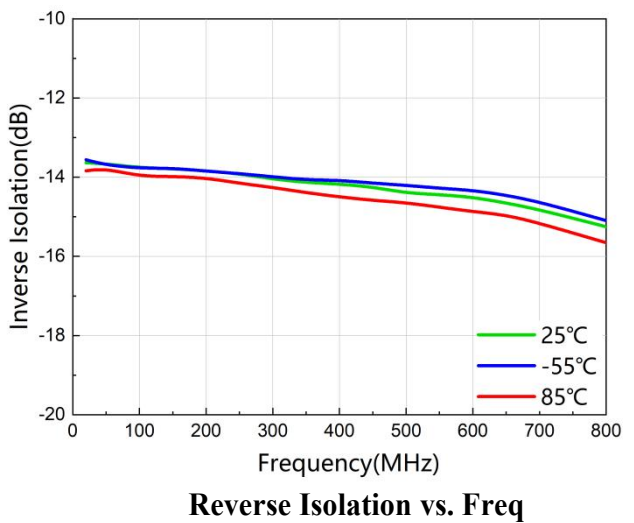
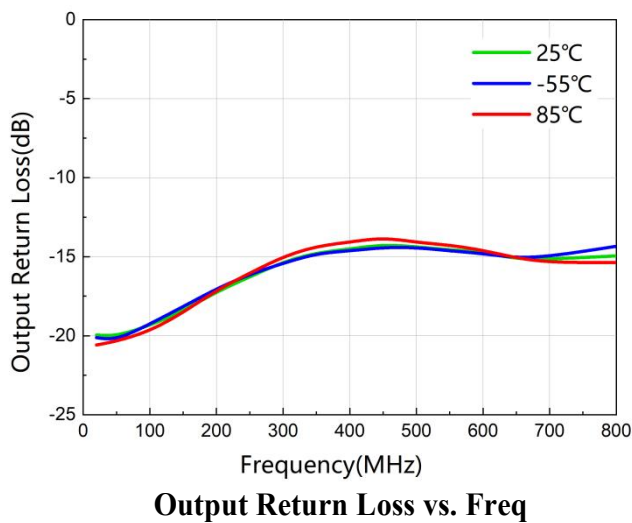
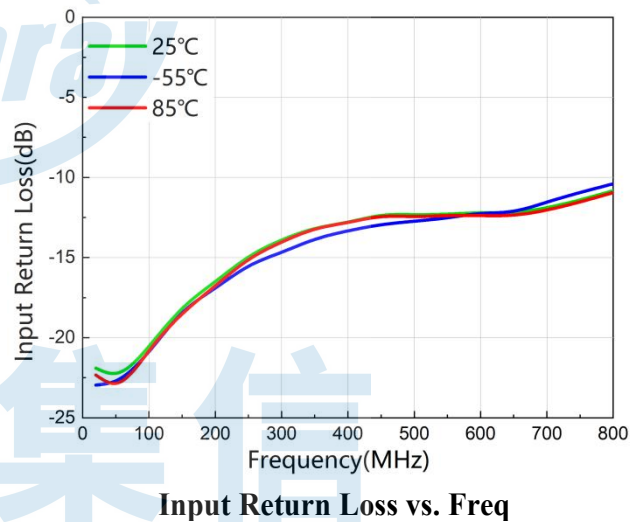
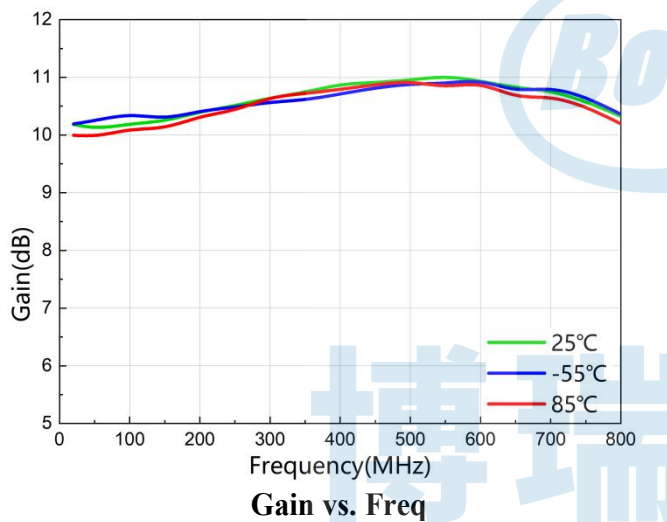


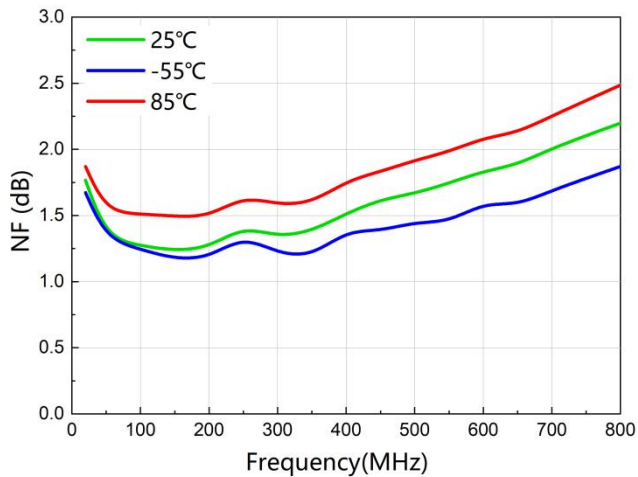
P_{out} , IDD vs P_{in} (700MHz)

Typical Performance((EVB test results at +9V supply voltage , 20MHz~700MHz, 25°C)

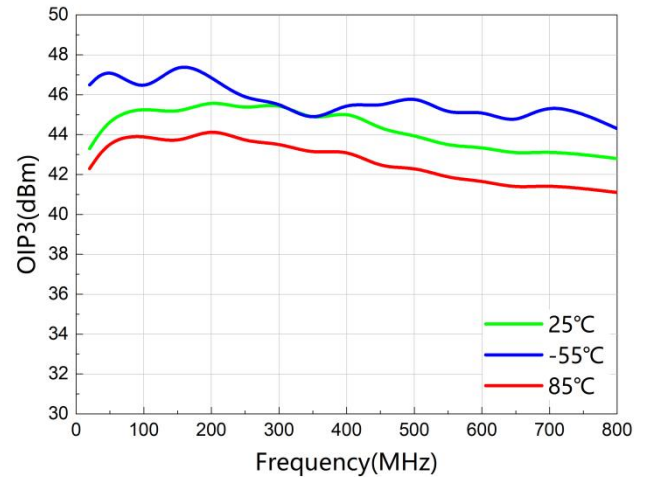
Parameters	Typ.										Units
Frequency	20	50	100	200	300	400	500	600	700		MHz
Gain	10.2	10.1	10.2	10.4	10.6	10.9	11.0	10.9	10.7		dB
Input Return Loss	-21.9	-22.2	-20.5	-16.5	-13.9	-12.8	-12.3	-12.2	-11.9		dB
Output Return Loss	-20.0	-20.0	-19.3	-17.2	-15.3	-14.5	-14.4	-14.7	-15.2		dB
Isolation	-13.6	-13.7	-13.8	-13.8	-14.0	-14.2	-14.4	-14.5	-14.8		dB
Input Power for 1dB Compression	19.5	19.3	19.0	19.3	19.0	18.7	17.8	17.8	17.6		dBm
Output Power for 1dB Compression	28.6	28.4	28.2	28.5	28.4	28.3	27.8	27.8	27.2		dBm
Output Third-Order Interception	43.3	44.9	45.4	45.8	45.7	45.3	44.0	43.4	43.2		dBm
Noise Figure	1.8	1.3	1.3	1.3	1.3	1.5	1.7	1.8	2.0		dB

Test Conditions: Vdd=+9V, I=226mA, OIP3 spacing=1MHz, Pout=+10dBm/tone, TA=+25°C

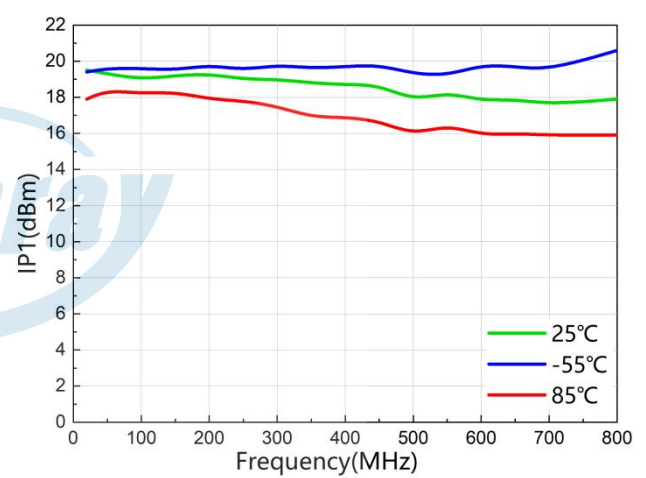
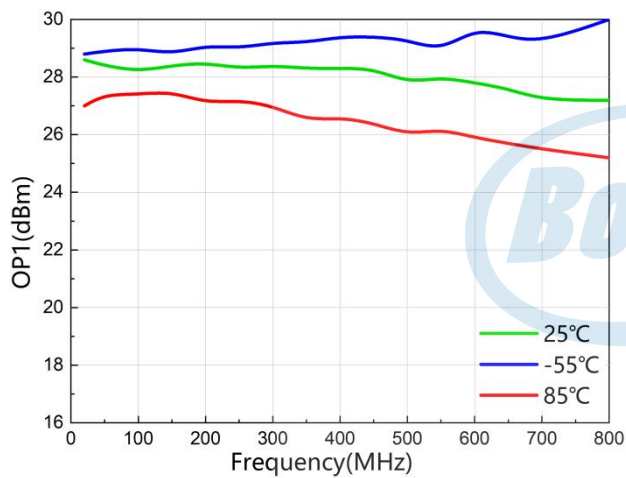




Noise Figure vs. Freq

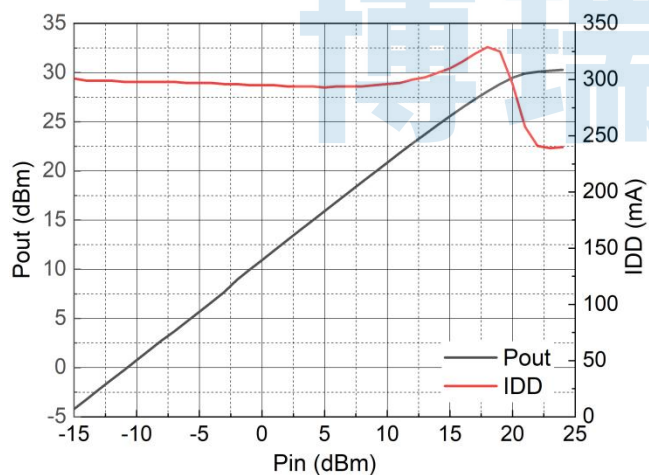


Output Third-Order Interception vs. Freq

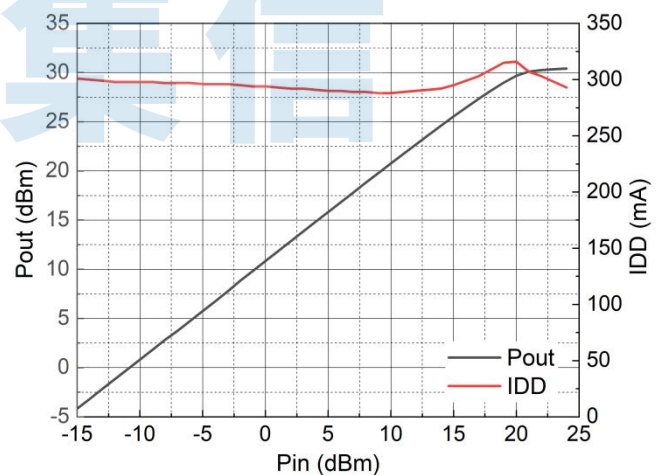


Output Power for 1dB Compression vs. Freq

Input Power for 1dB Compression vs. Freq

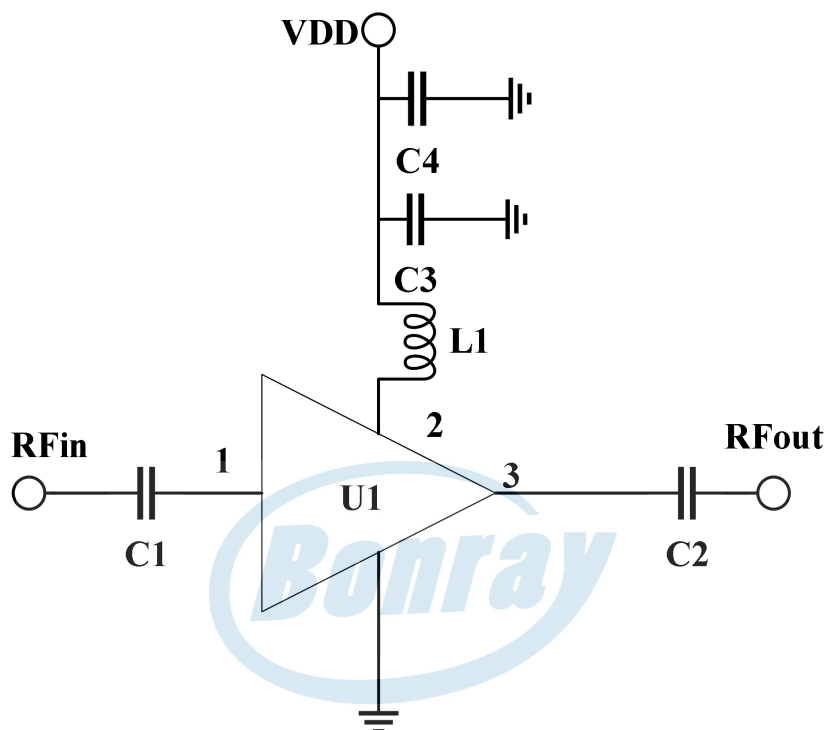


P_{out}, IDD vs P_{in} (400MHz)



P_{out}, IDD vs P_{in} (700MHz)

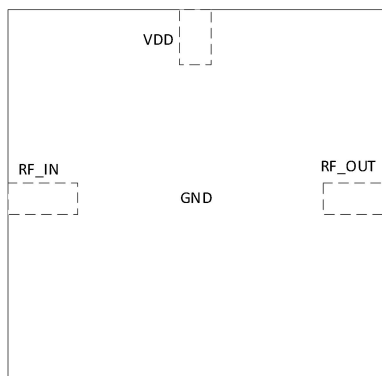
Typical Application Schematic



Bill of Material

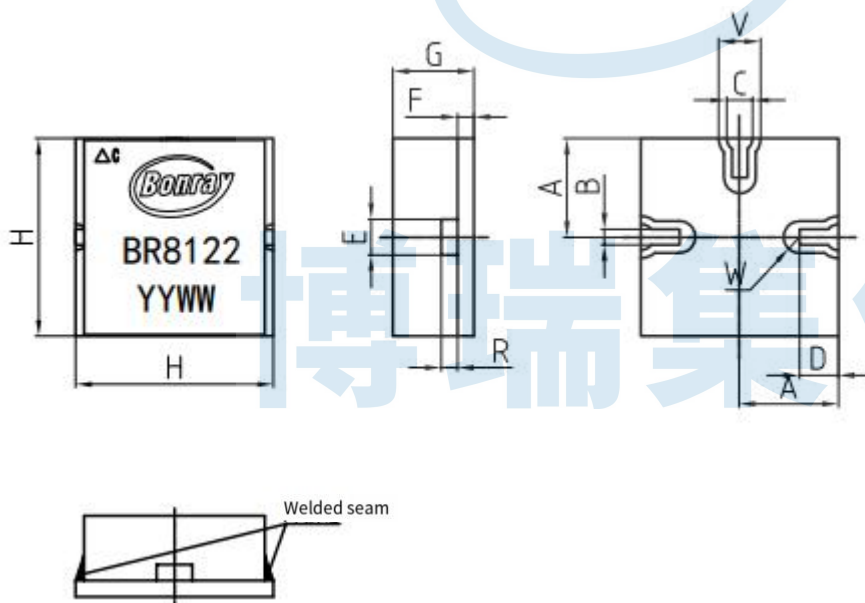
Reference Designator	Package Size	Value	P/N
U1	Compatible with SMO-8C	Anti-blocking amplifier	BR8122AFF
L1	0603	3.3 uH	1008AF-332X_EC
C1, C2	0402	10nF	GRM155R71H103JA88D
C3	0402	1nF	GRM1555C1H102JA01D
C4	0402	1uF	C1005X5R1V105K050BC

Pin Configuration and Description



Pin number	Pin name	Description
1	RFin	RF input pin. The pin is AC coupled
2	VDD	Power supply pin.
3	RFout	RF output pin. The pin is AC Coupled
4	GND	Ground pin. The pin must be connected to the RF/DC ground.

Package Dimensions (unit: mm)

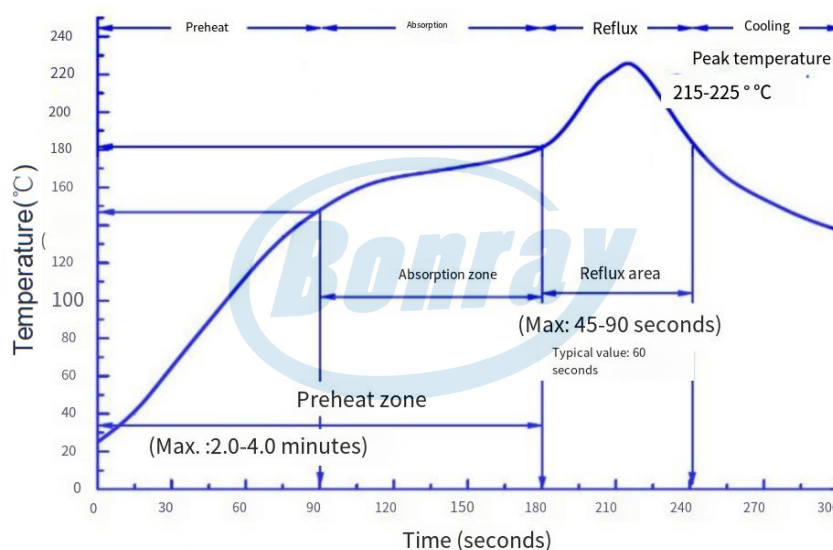


Numbering	Min.	Typ.	Max.
A	5.9	6.1	6.3
B	0.9	1.0	1.1
C	1.5	1.6	1.7
D	2.3	2.4	2.5
E	3.2	3.4	3.6
F	-	1.0	-
G	4.8	5.0	5.2
H	12.1	12.2	12.3
R	0.8	1.0	1.2
V	2.2	2.4	2.6
W	-	0.99	-

4 PIN description: The pin is GND grounded and needs to be welded. The weld surface size is 12.2mm x 12.2mm rectangle minus the pin pin avoidance size.

Handling Precautions:

1. The product is an ESD-sensitive device. Proper electrostatic protection measures must be implemented during transportation, assembly, and operation.
2. The component is classified as Moisture Sensitivity Level 3 (MSL3). Storage, handling, transportation, and packaging must comply with IPC/JEDEC J-STD-033 standards.
3. Ensure reliable grounding by connecting both the GND pin and the bottom metallized pad to the system ground plane.
4. Recommended assembly method: SMT (Surface Mount Technology) with Sn63/Pb37 solder paste (melting point: 183°C). Refer to the attached reflow temperature profile for process parameters.



The provided reflow temperature profile is a general recommendation. Actual parameters may vary depending on the substrate and reflow oven performance. The measured substrate temperature during reflow must not exceed the maximum assembly temperature specified in the absolute maximum ratings.

5. If rework or repair is necessary, the device must be baked according to Section 1 requirements prior to any heating process to prevent thermal damage. The total number of reflow and rework cycles shall not exceed three (3).
6. Customers must evaluate environmental conditions to determine if protective coating is required. For applications exposed to salt spray or corrosive environments, conformal coating (e.g., acrylic, silicone) must be applied after soldering and cleaning to enhance environmental resistance.
7. Due to the circuit architecture, dynamic current increases significantly near output power of 1dB Compression. To prevent interference with other ICs on the system board, it is recommended to power this device with a dedicated LDO (Low Dropout Regulator) capable of >400mA output current.
8. For operation at supply voltages $\geq 7V$, a thermal pad (exposed copper area) must be added on the PCB underside, aligned with a structural heatsink (PCB window opening to contact the chassis); Optional front-side heatsink implementation should be determined by system-level thermal simulation results.